



Electrical and Computer Engineering Research Facility



University of Alberta, Edmonton, Alberta

## Optimization of Thin Film Heater/Sensor Design for Miniature Devices Using Finite Element Analysis

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Femlab-2005, Boston



# Need for thin film resistive heaters

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- Compatible with microfluidic devices.
- Standard semi-conductor fabrication procedures.
- Very low power consumption.
- Rapid change in temperature
  - both heating and cooling.
- Low thermal mass.
- Precision localized heating.

Peltier elements:  
**3-5 °C /second**  
Thin film resistive  
heaters:  
**20-50 °C/second**



# Aims and objectives

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- Develop a paradigm for thin-film resistive heaters to derive rules for design.
- Parametric study to define the temperature uniformity of the resistive heaters.
- Simultaneous heating and temperature sensing capabilities.
- Precision temperature stability.



# Applications

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- Microfluidic devices for practical medical diagnosis applications.
- Require complex bio-chemical reactions to be catalyzed at precision temperature environment.
- Low-power, portable, economical and localized heating applications.

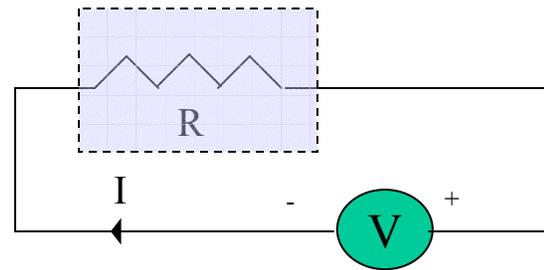


# Principle of resistive heating

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Involves passing a direct current through the film. The power generated due to the resistance is calculated by Ohm's law.

$$P = VI = I^2 R = \frac{V^2}{R}$$



It is assumed that almost all the electrical power generated is dissipated into heat.

$$\nabla^2 T + \frac{q_{gen}}{k} = \frac{\rho c}{k} \frac{\partial T}{\partial t}$$

T is a function of location and time,  
 $Q_{gen}$  is the heat generated per unit volume  
K is the thermal conductivity of the material

$\rho$  is the mass density of the material.  
C is the specific heat of the material.

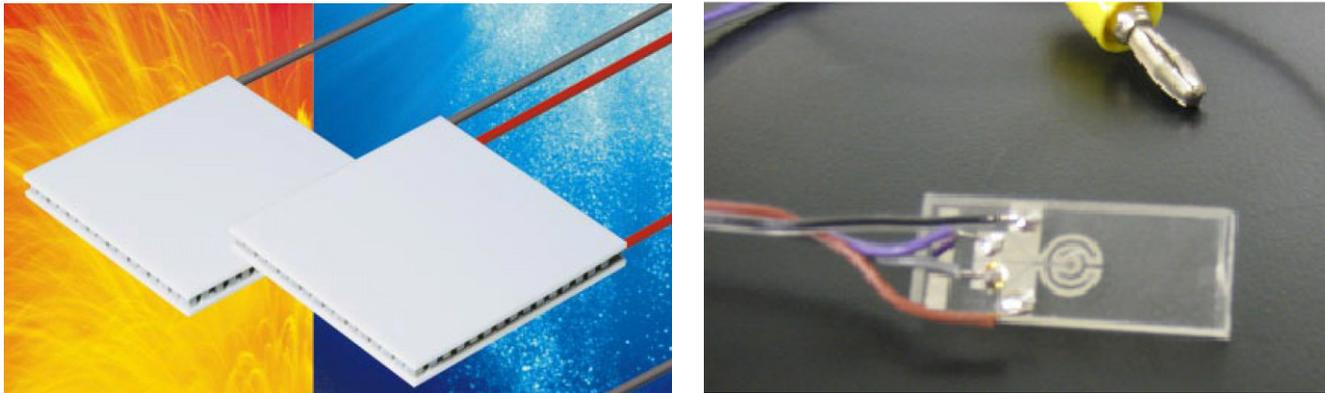


# Need for finite element analysis

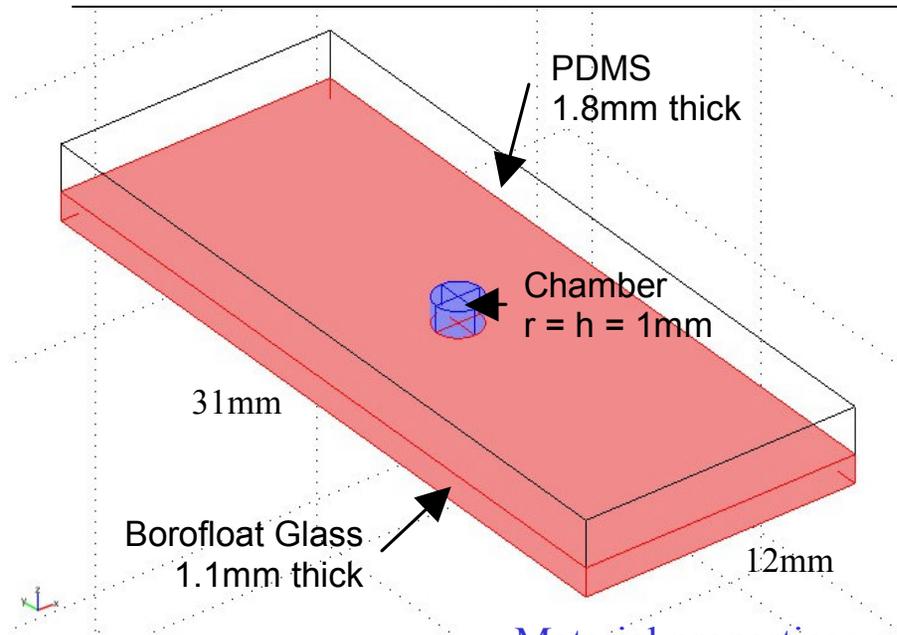
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- Not all of the power dissipation is uniform.
- Minor variations of the heat-flux path generates non-uniformities.
- Temperature uniformity is a complex function of the geometry and environment of the thin-film heater.

*First principles modeling would be infeasible!*



# Geometry of representative chip



## Boundary Conditions

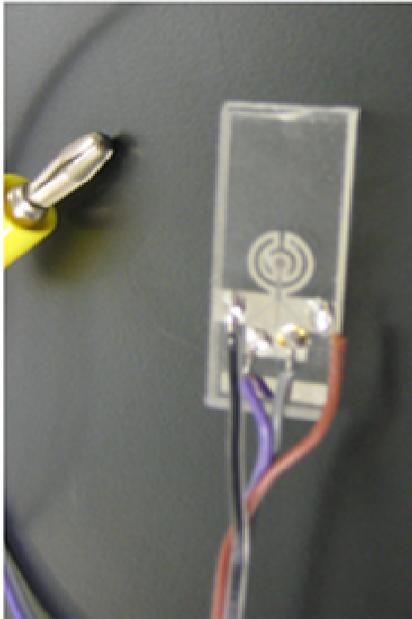
- Natural convection and radiation on top surface.
- Constant Room Temperature on the sides.
- Thermal insulation on the bottom surface.

## Material properties used in FEA simulations

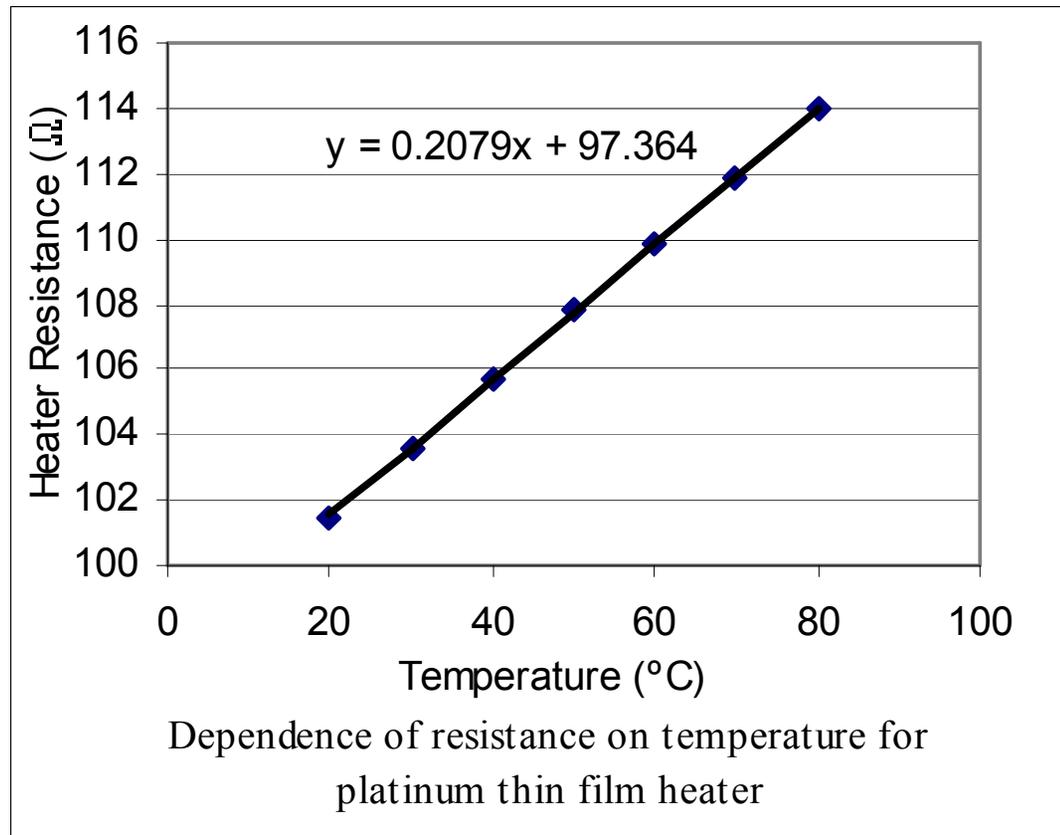
Material	Thermal Conductivity (W/m·K)	Specific Heat Capacity (J/kg·K)	Density (kg/m <sup>3</sup> )
Glass	1.11	830	2200
PDMS	0.18	1100	1030
Water	0.58	4187	1000
Platinum	72	133	21500



# Calibration experiments



## Least squares method

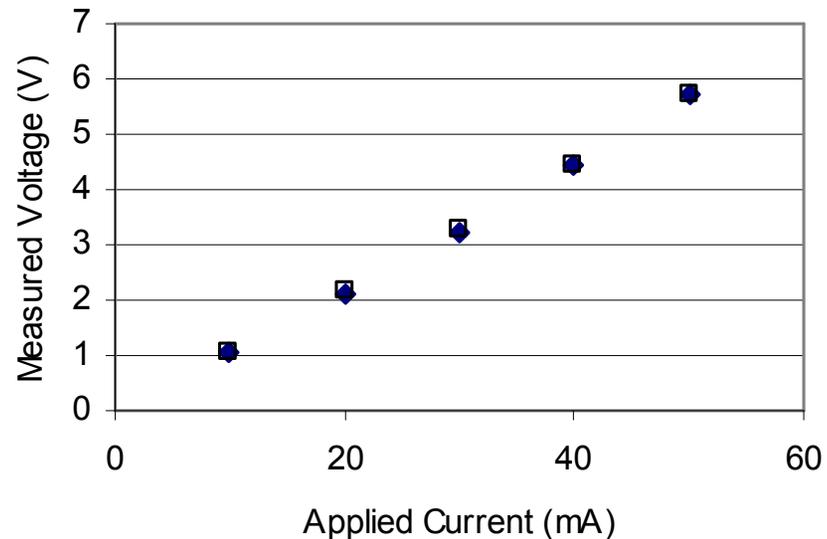
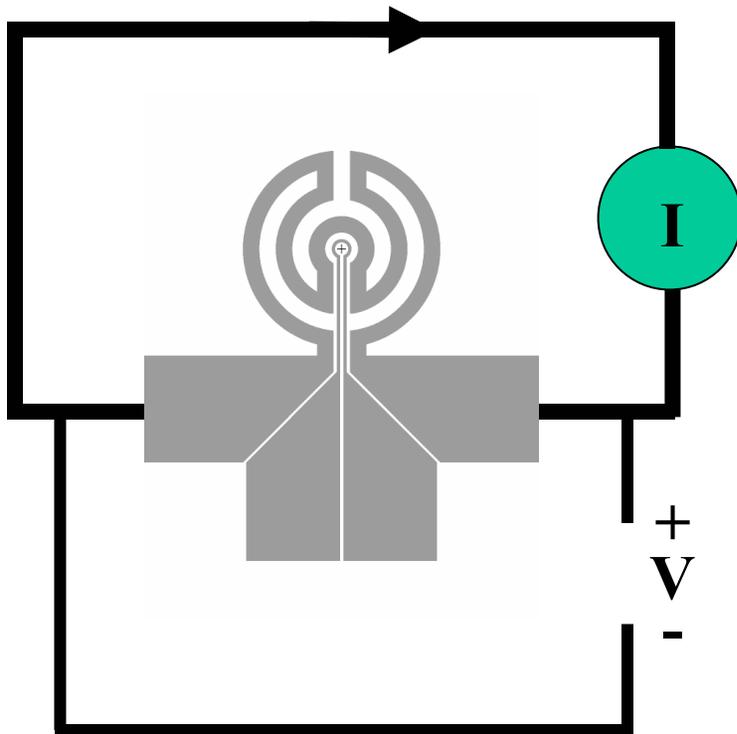


Differs from bulk materials  
Resistivity =  $f(\text{temperature})$



# Validation Experiments – approach 1

For non-optimized heaters testing was done - Apply a known current and measure the resulting voltage



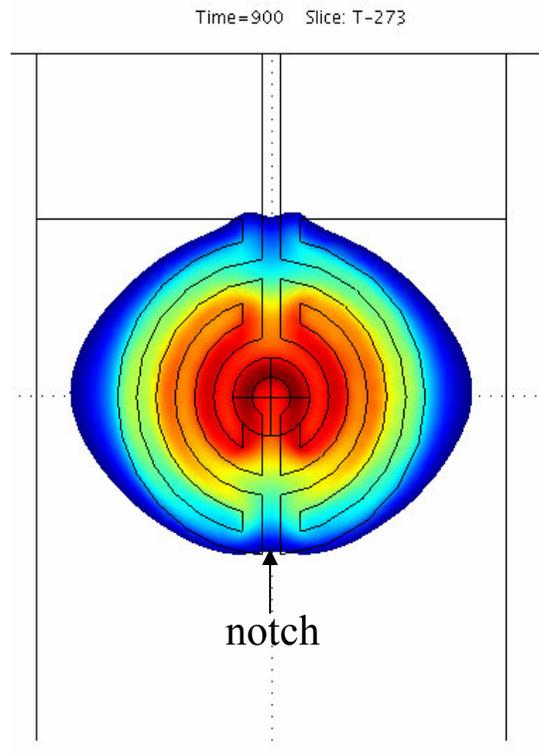
◆ Simulated Data □ Actual Measured Data

Comparison of simulated and actual measured voltages

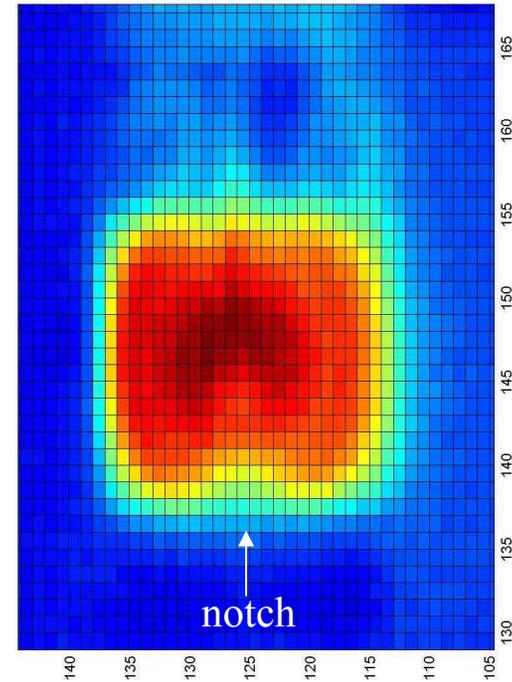


# Validation experiments – approach 2

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Simulation

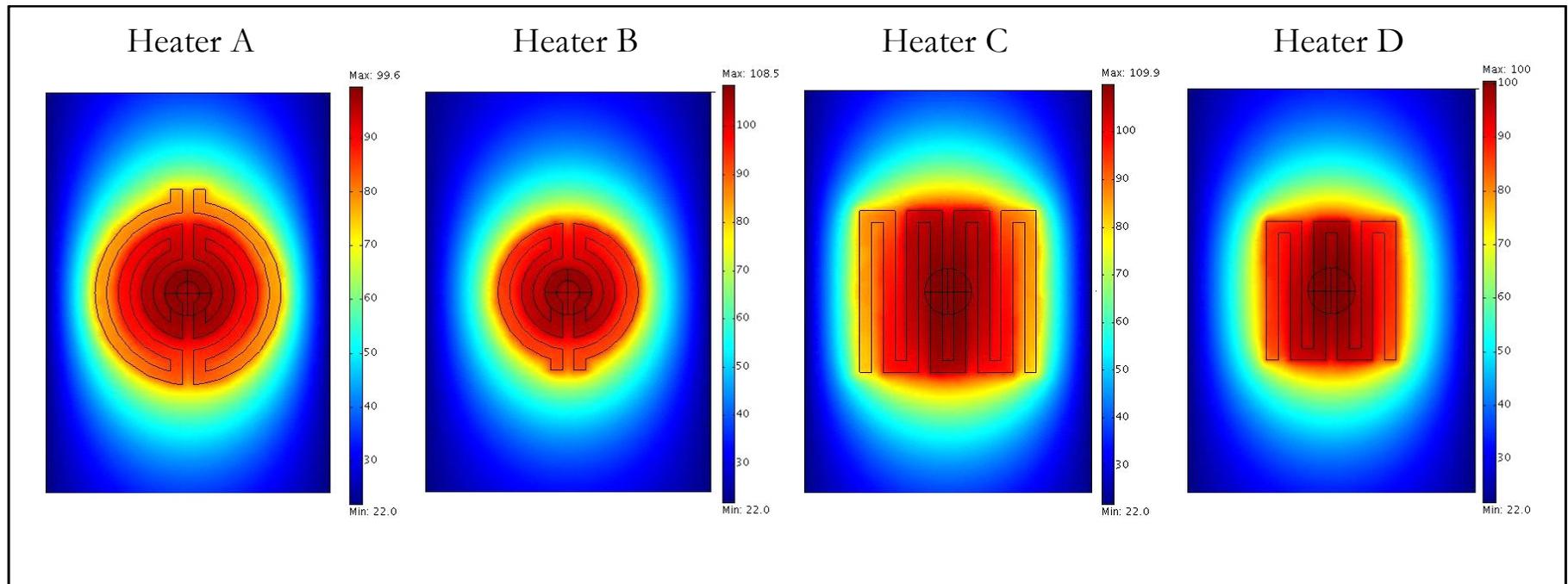


IR image of actual chip

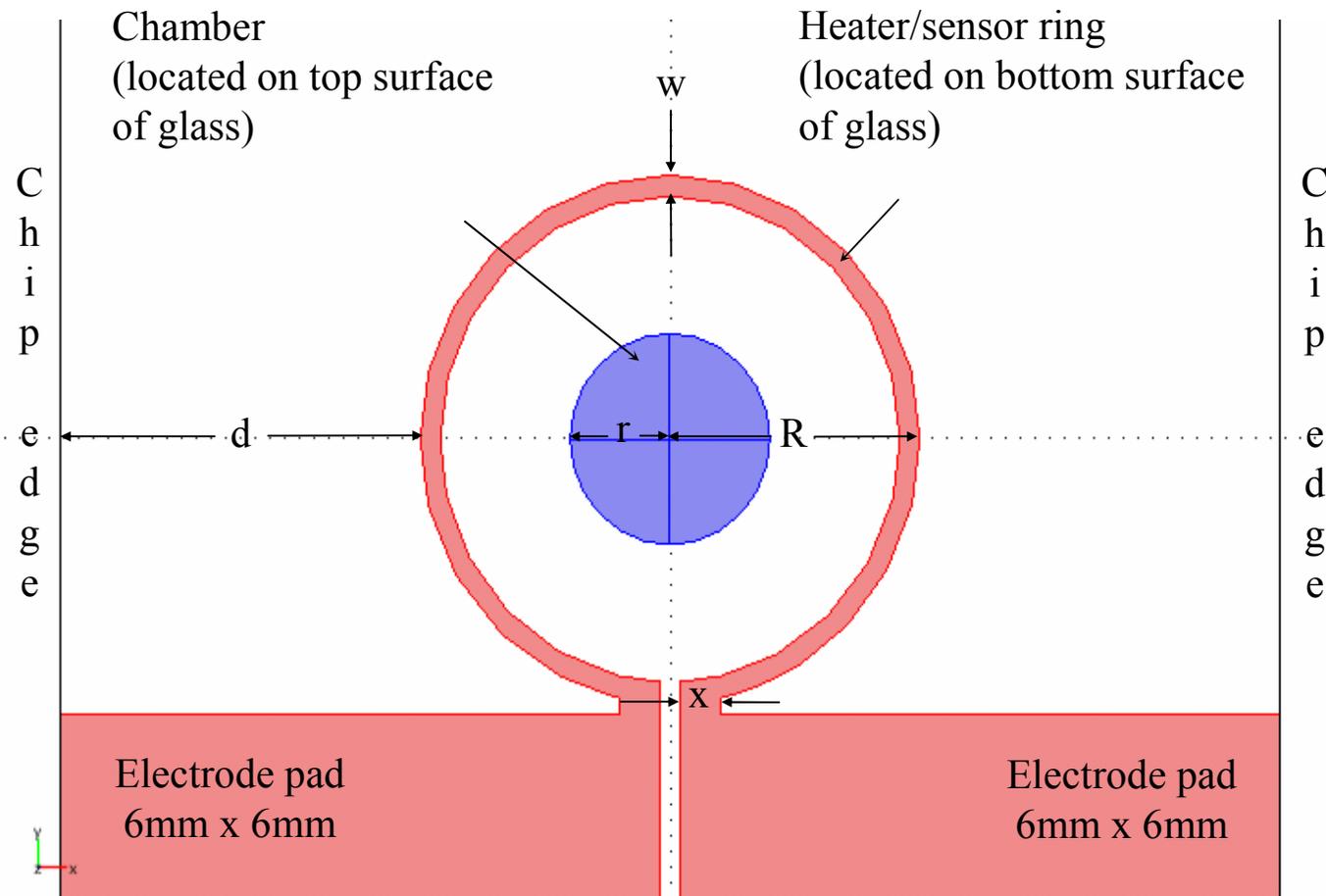


# Simulation outcome with different heater geometries

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# Single ring heater/sensor geometry



# Environment

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- General heat transfer (htgt) mode of the heat transfer module was used to simulate the heat transfer.
- Lagrange quadratic elements
- 200K -300L dofs.
- The metal film being very thin were modeled using the shell mode in 2D (shell conductive media DC).



# Parametric study

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Primarily the temperature dependency is a complex function of -

- (a) Electrode pad connection width ( $x$ ).
- (b) Proximity of chip edges ( $d$ ).
- (c) Chamber height ( $h$ ).
- (d) Heater radius ( $R$ ).
  
- (e) Material used to fabricate the chip.
- (f) The temperatures to which the chip is heated.



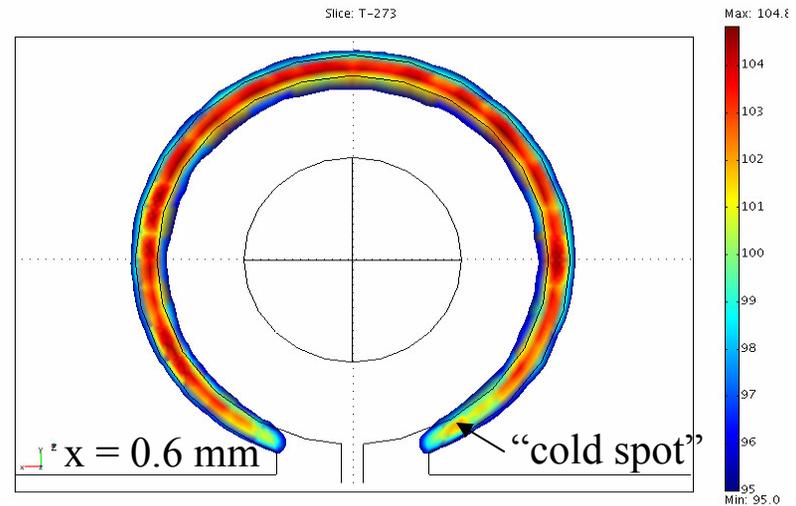
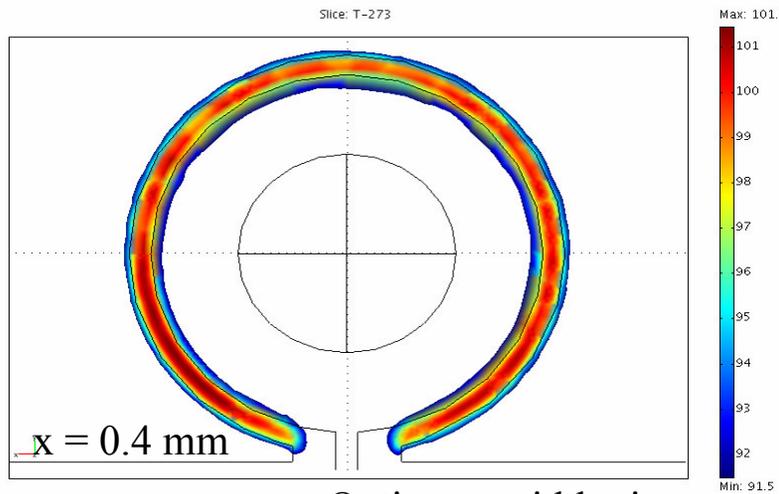
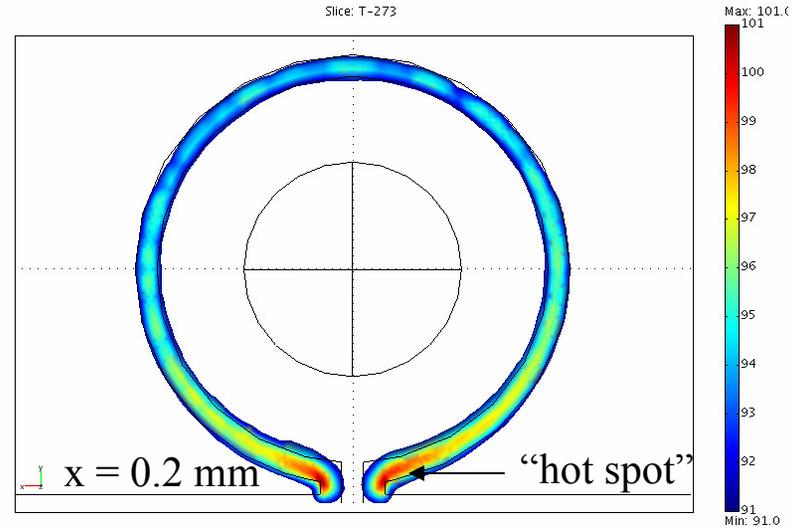
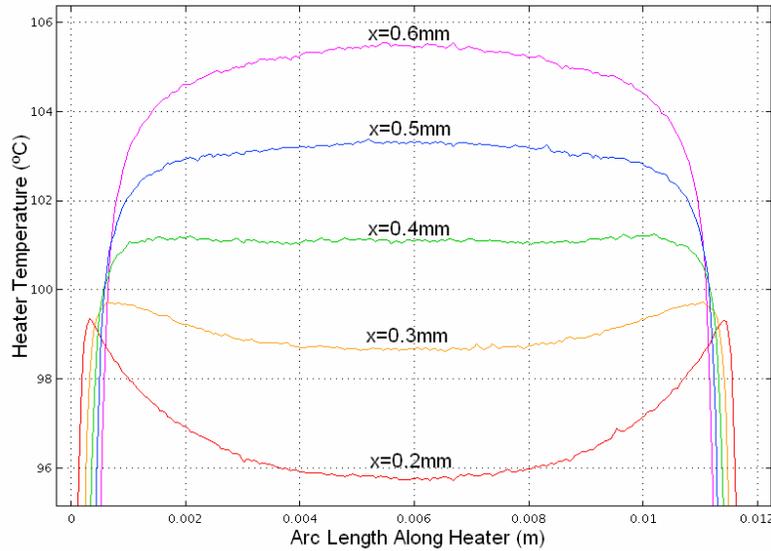
# Requirement-I: Temperature uniformity of the heating/sensing element

- (a) Electrode pad connection width (x).
- (b) Proximity of chip edges (d).

Help avoid using separate elements for heating and sensing!



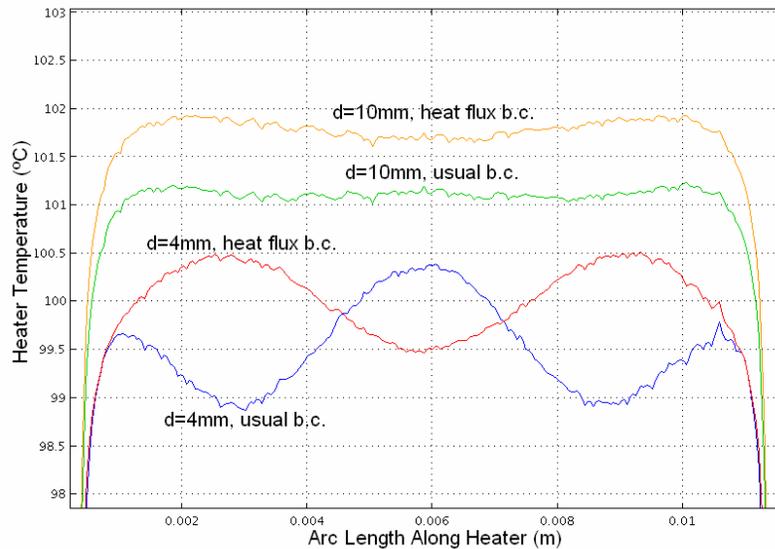
# Effect of electrode pad connection width (x)



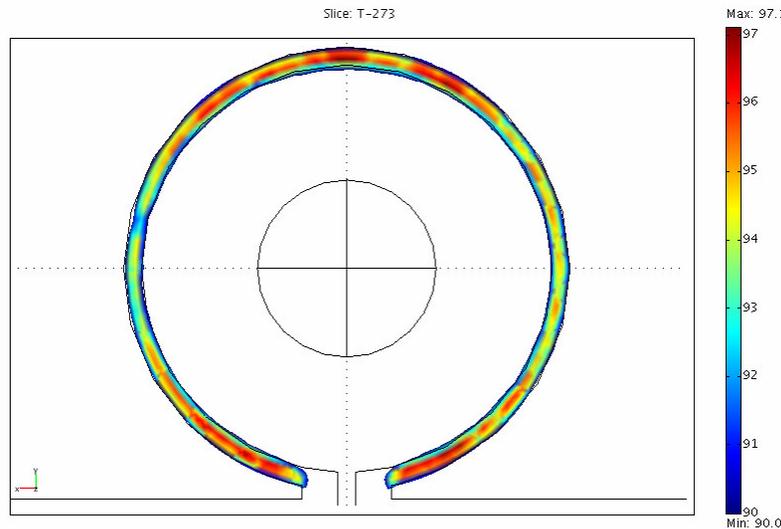
Optimum width gives uniform temperature distribution



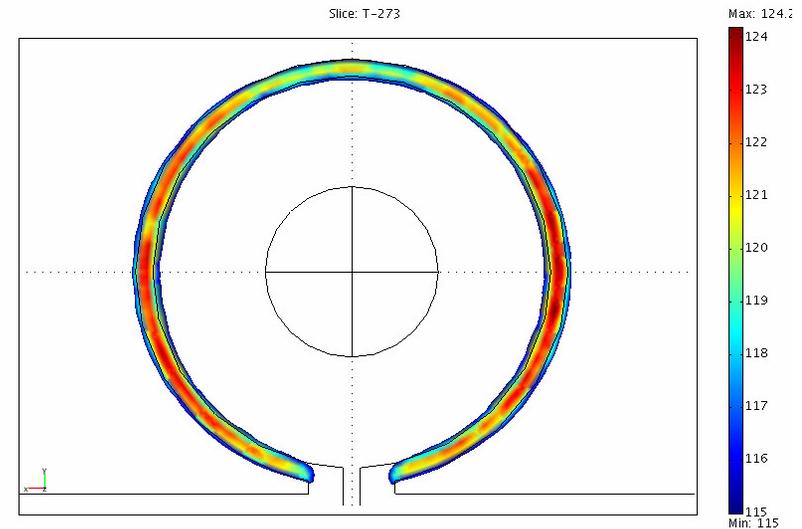
# Effect of proximity of the chip edges (d)



If edges are too close, heater temperature distribution very sensitive to external boundary conditions.



Usual boundary conditions  
d = 4 mm



All boundary conditions are heat flux  
d = 4 mm



# Requirement-II: Temperature uniformity chamber

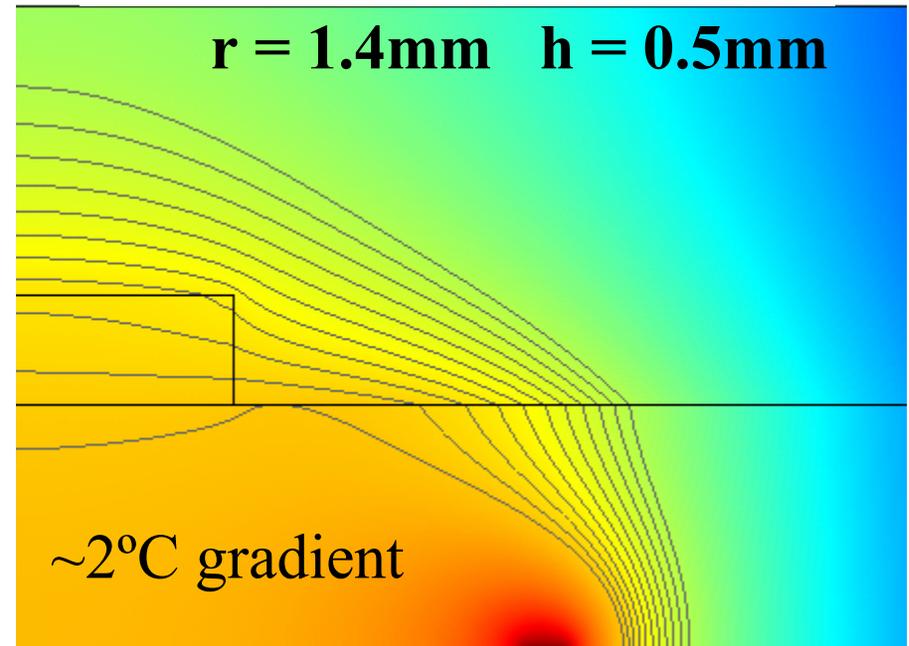
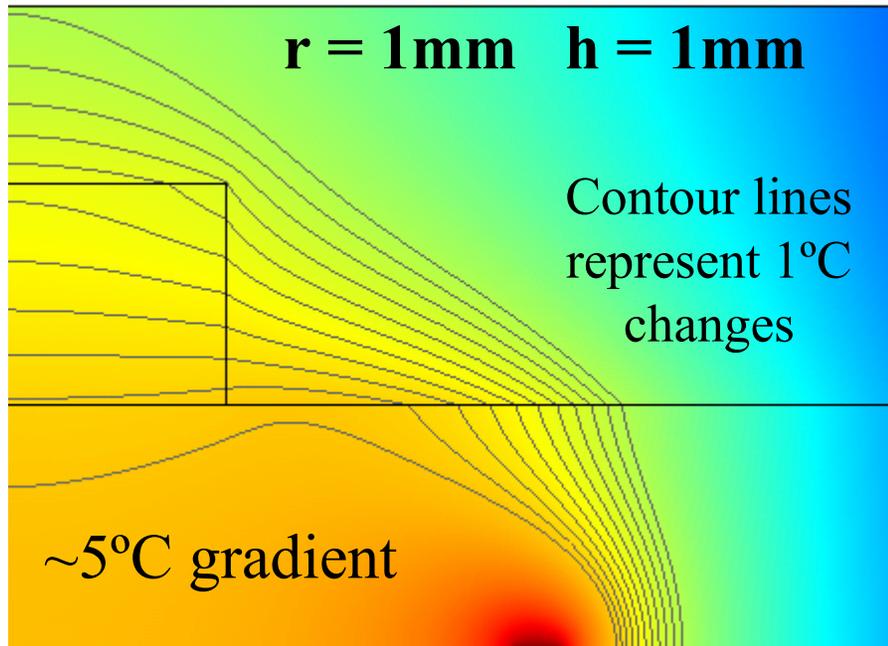
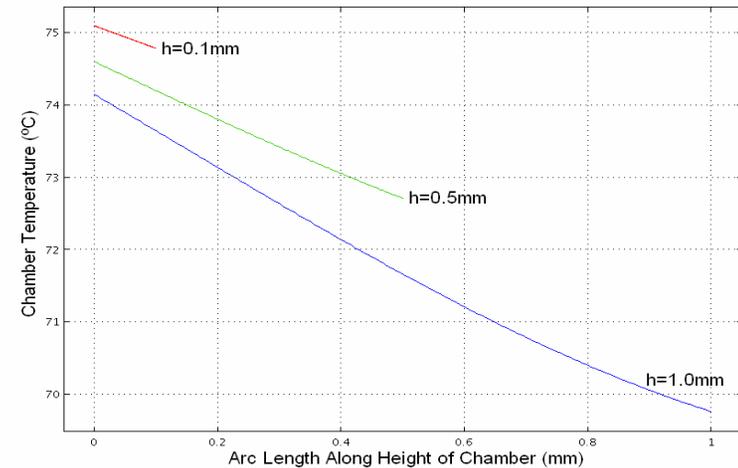
- (c) Chamber height ( $h$ ).
- (d) Heater radius ( $R$ ).

Uniform temperature might enhance uniform reaction progression within the fluidic chamber!

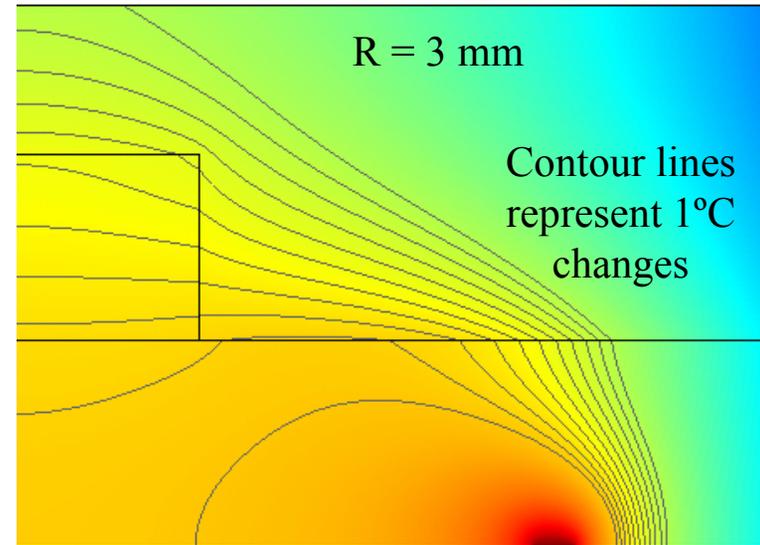
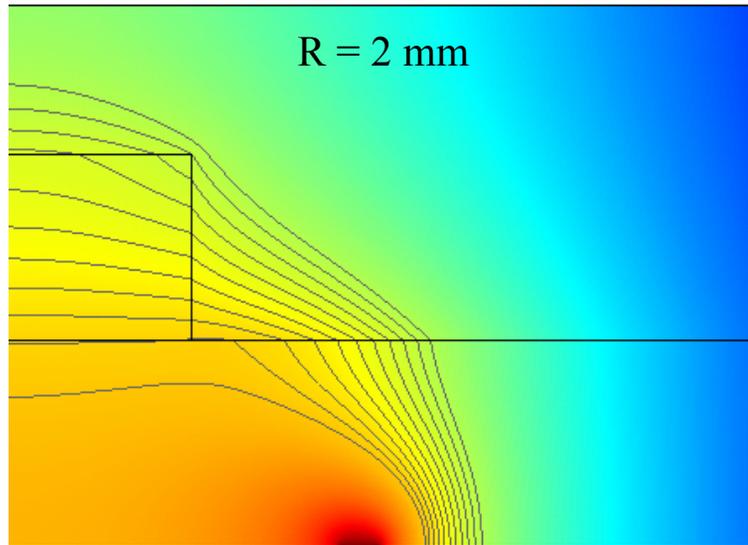
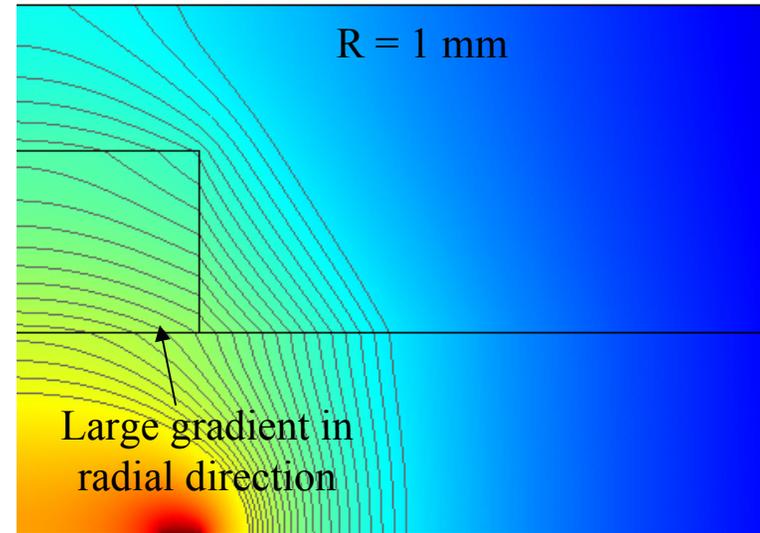
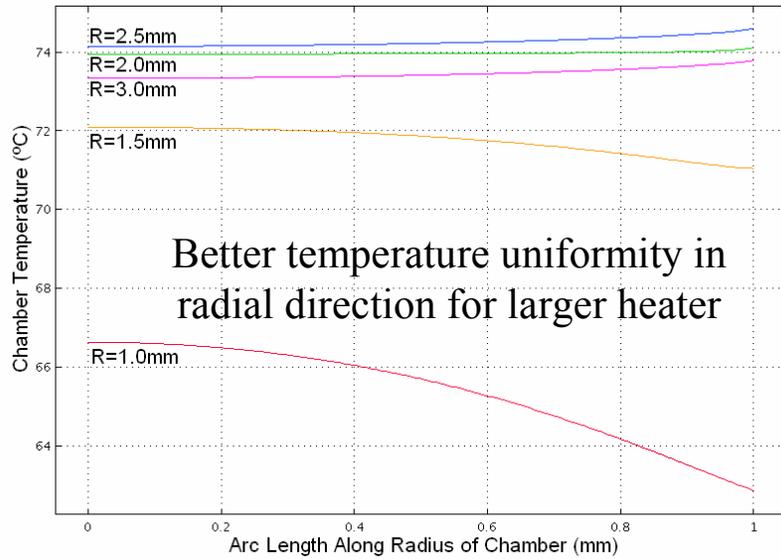


# Effect of chamber height (h)

Shorter chamber gives better temperature uniformity in the z-direction of the chamber



# Effect of heater radius (R)



# Summary

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- Pt thin films useful for catalyzing many bio-chemical reactions requiring precision temperature.
- Heater and the temperature sensing element the same, hence, less interconnects facilitate scaling for high throughput applications.
- Low power, localized heating elements in place that forms a practical and portable diagnostic assay.
- Design such that no additional bio-compatible layer is required; heat flow engineered such that non-contact heating with bio-fluids is efficiently possible.

